Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/500,572	SHIMADA, AKIHIRO
Examiner	Art Unit

Nguyen N. Hanh

2834

SEARCHED					
Class	Subclass	Date	Examiner		
310	52	10/19/2006	HN		
310	54	10/19/2006	HN		
310	58	10/19/2006	HN		
310	64	10/19/2006	HN		
310	90	10/19/2006	HN		
310	90.5	10/19/2006	HN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Consult Pang Le Prino Examina for Albanance	4 i 0/19/06	HN			